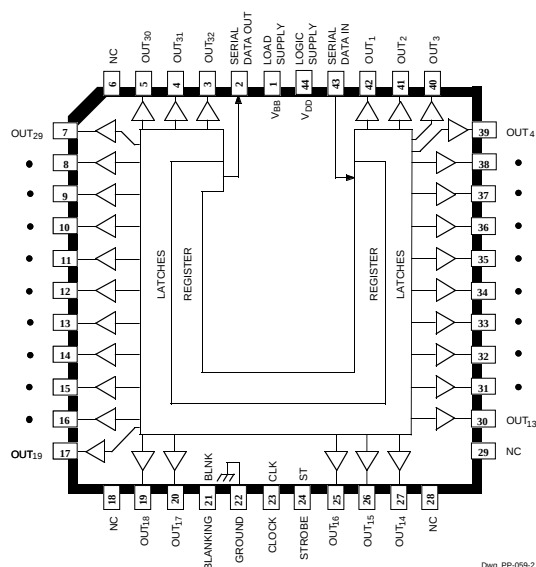


UCN5818EPF



Logic Supply Voltage, V_{DD}	15 V
Driver Supply Voltage, V_{BB}	60 V
Continuous Output Current, I_{OUT}	-40 mA to +15 mA
Input Voltage Range, V_{IN}	-0.3 V to $V_{DD} + 0.3$ V
Package Power Dissipation, P_D (UCN5818AF)	3.5 W*
(UCN5818EPF)	2.3 W†
Operating Temperature Range, T_A	-20°C to +85°C
Storage Temperature Range, T_S	-55°C to +150°C

* Derate at rate of 28 mW/°C above $T_A = +25^\circ\text{C}$
† Derate at rate of 18 mW/°C above $T_A = +25^\circ\text{C}$

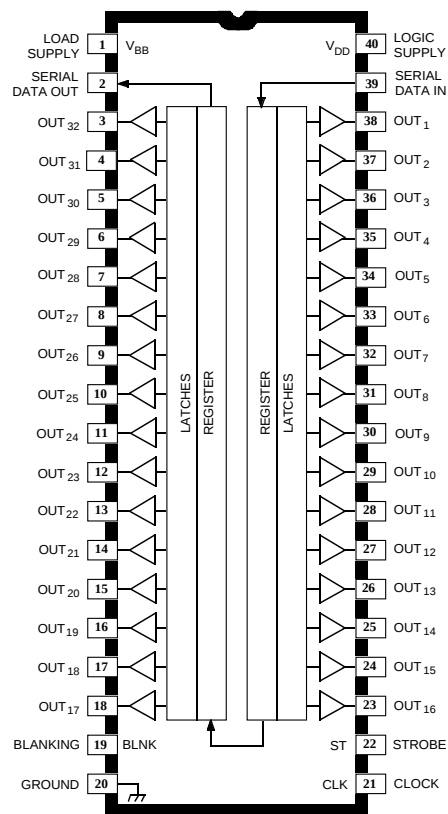
- Low-Power CMOS Logic and Latches
- Reduced Supply Current Requirements
- Improved Replacements for SN75518N/FN

Always order by complete part number, e.g., **UCN5818EPF**.

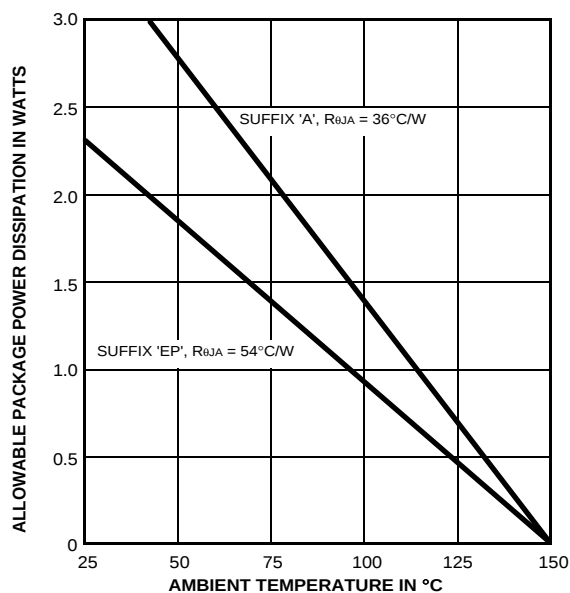
5818-F

32-BIT SERIAL-INPUT, LATCHED SOURCE DRIVERS WITH ACTIVE-DMOS PULL-DOWNS

UCN5818AF

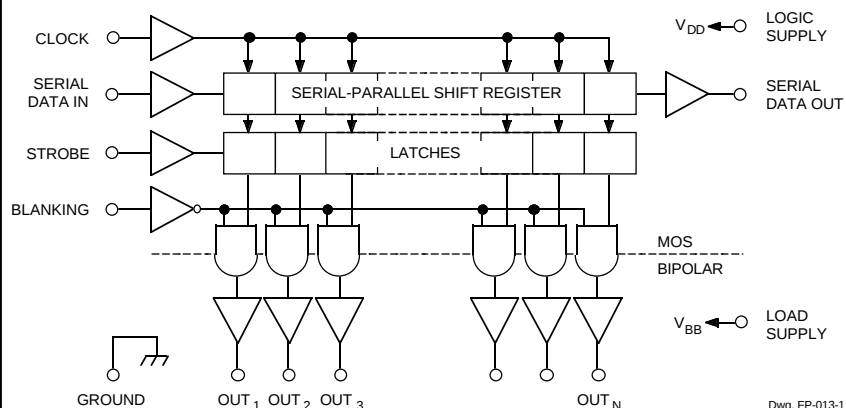


Dwg. PP-029-4



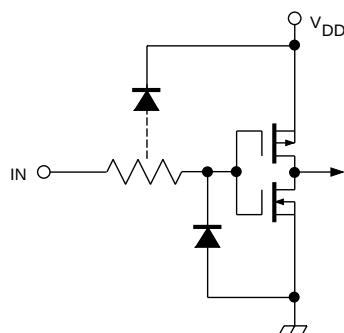
Dwg. GP-025B

FUNCTIONAL BLOCK DIAGRAM



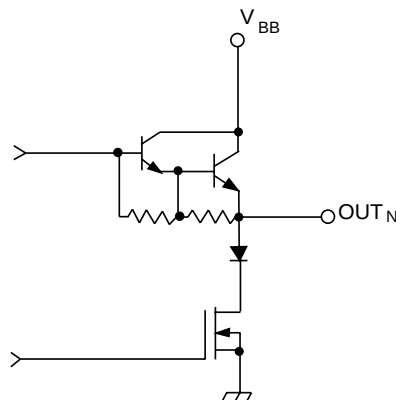
Dwg. FP-013-1

TYPICAL INPUT CIRCUIT



Dwg. EP-010-5

TYPICAL OUTPUT DRIVER



Dwg. No. A-14,219

5818-F
32-BIT SERIAL-INPUT,
LATCHED SOURCE DRIVERS
WITH ACTIVE-DMOS PULL-DOWNS

ELECTRICAL CHARACTERISTICS at $T_A = +25^\circ\text{C}$, $V_{BB} = 60\text{ V}$ unless otherwise noted.

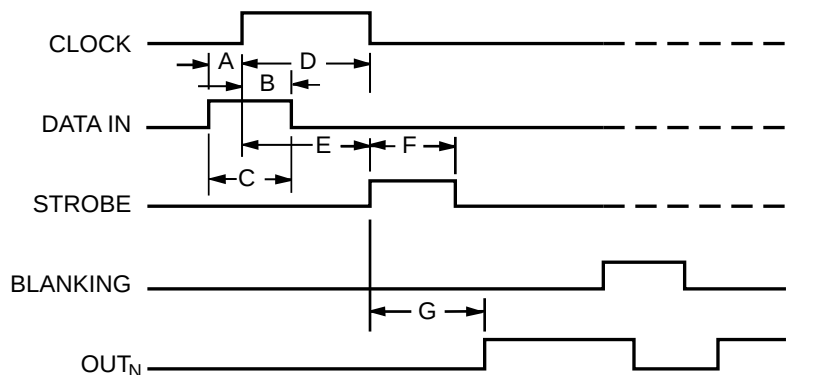
Characteristic	Symbol	Test Conditions	Limits @ $V_{DD} = 5\text{ V}$			Limits @ $V_{DD} = 12\text{ V}$			Units
			Min.	Typ.	Max.	Min.	Typ.	Max.	
Output Leakage Current	I_{CEX}	$V_{OUT} = 0\text{ V}$, $T_A = +70^\circ\text{C}$	—	-5.0	-15	—	-5.0	-15	μA
Output Voltage	$V_{OUT(1)}$	$I_{OUT} = -25\text{ mA}$	58	58.5	—	58	58.5	—	V
	$V_{OUT(0)}$	$I_{OUT} = 1\text{ mA}$	—	2.0	3.0	—	—	—	V
		$I_{OUT} = 2\text{ mA}$	—	—	—	—	2.0	3.5	V
Output Pull-Down Current	$I_{OUT(0)}$	$V_{OUT} = 5\text{ V to }V_{BB}$	2.0	3.5	—	—	—	—	mA
		$V_{OUT} = 20\text{ V to }V_{BB}$	—	—	—	8.0	13	—	mA
Input Voltage	$V_{IN(1)}$		3.5	—	5.3	10.5	—	12.3	V
	$V_{IN(0)}$		-0.3	—	+0.8	-0.3	—	+0.8	V
Input Current	$I_{IN(1)}$	$V_{IN} = V_{DD}$	—	0.05	0.5	—	0.1	1.0	μA
	$I_{IN(0)}$	$V_{IN} = 0.8\text{ V}$	—	-0.05	-0.5	—	-0.1	-1.0	μA
Serial Data Output Voltage	$V_{OUT(1)}$	$I_{OUT} = -200\text{ }\mu\text{A}$	4.5	4.7	—	11.7	11.8	—	V
	$V_{OUT(0)}$	$I_{OUT} = 200\text{ }\mu\text{A}$	—	200	250	—	100	200	mV
Maximum Clock Frequency	f_{clk}		3.3*	—	—	—	—	—	MHz
Supply Current	$I_{DD(1)}$	All Outputs High	—	100	300	—	200	500	μA
	$I_{DD(0)}$	All Outputs Low	—	100	300	—	200	500	μA
	$I_{BB(1)}$	Outputs High, No Load	—	3.0	6.0	—	3.0	6.0	mA
	$I_{BB(0)}$	Outputs Low	—	10	100	—	10	100	μA
Blanking to Output Delay	t_{PHL}	$C_L = 30\text{ pF}$, 50% to 50%	—	2000	—	—	1000	—	ns
	t_{PLH}	$C_L = 30\text{ pF}$, 50% to 50%	—	1000	—	—	850	—	ns
Output Fall Time	t_f	$C_L = 30\text{ pF}$, 90% to 10%	—	1450	—	—	650	—	ns
Output Rise Time	t_r	$C_L = 30\text{ pF}$, 10% to 90%	—	650	—	—	700	—	ns

Negative current is defined as coming out of (sourcing) the specified device terminal.

* Operation at a clock frequency greater than the specified minimum value is possible but not warranted.

5818-F

32-BIT SERIAL-INPUT, LATCHED SOURCE DRIVERS WITH ACTIVE-DMOS PULL-DOWNS



Dwg. No. A-12,649A

TIMING REQUIREMENTS

(T_A = +25°C, V_{DD} = 5 V, Logic Levels are V_{DD} and Ground)

- A. Minimum Data Active Time Before Clock Pulse (Data Set-Up Time) **75 ns**
- B. Minimum Data Active Time After Clock Pulse (Data Hold Time) **75 ns**
- C. Minimum Data Pulse Width **150 ns**
- D. Minimum Clock Pulse Width **150 ns**
- E. Minimum Time Between Clock Activation and Strobe **300 ns**
- F. Minimum Strobe Pulse Width **100 ns**
- G. Typical Time Between Strobe Activation and Output Transistion **500 ns**

Timing is representative of a 3.3 MHz clock. Higher speeds may be attainable with increased supply voltage; operation at high temperatures will reduce the specified maximum clock frequency.

Serial Data present at the input is transferred to the shift register on the logic "0" to logic "1" transition of the CLOCK input pulse. On succeeding CLOCK pulses, the registers shift data information towards the SERIAL DATA OUTPUT. The SERIAL DATA must appear at the input prior to the rising edge of the CLOCK input waveform.

Information present at any register is transferred to the respective latch when the STROBE is high (serial-to-parallel conversion). The latches will continue to accept new data as long as the STROBE is held high. Applications where the latches are bypassed (STROBE tied high) will require that the BLANKING input be high during serial data entry.

When the BLANKING input is high, the output source drivers are disabled (OFF); the DMOS sink drivers are ON, the information stored in the latches is not affected by the BLANKING input. With the BLANKING input low, the outputs are controlled by the state of their respective latches.

TRUTH TABLE

Serial Data Input	Clock Input	Shift Register Contents						Serial Data Output	Strobe Input	Latch Contents						Blanking	Output Contents					
		I ₁	I ₂	I ₃	...	I _{N-1}	I _N			I ₁	I ₂	I ₃	...	I _{N-1}	I _N		O ₁	O ₂	O ₃	...	O _{N-1}	O _N
H	┌	H	R ₁	R ₂	...	R _{N-2}	R _{N-1}	R _{N-1}														
L	┐	L	R ₁	R ₂	...	R _{N-2}	R _{N-1}	R _{N-1}														
X	┐	R ₁	R ₂	R ₃	...	R _{N-1}	R _N	R _N														
		X	X	X	...	X	X	X	L	R ₁	R ₂	R ₃	...	R _{N-1}	R _N							
		P ₁	P ₂	P ₃	...	P _{N-1}	P _N	P _N	H	P ₁	P ₂	P ₃	...	P _{N-1}	P _N	L						
										X	X	X	...	X	X	H						
																	L	L	L	...	L	L

L = Low Logic Level H = High Logic Level X = Irrelevant P = Present State R = Previous State

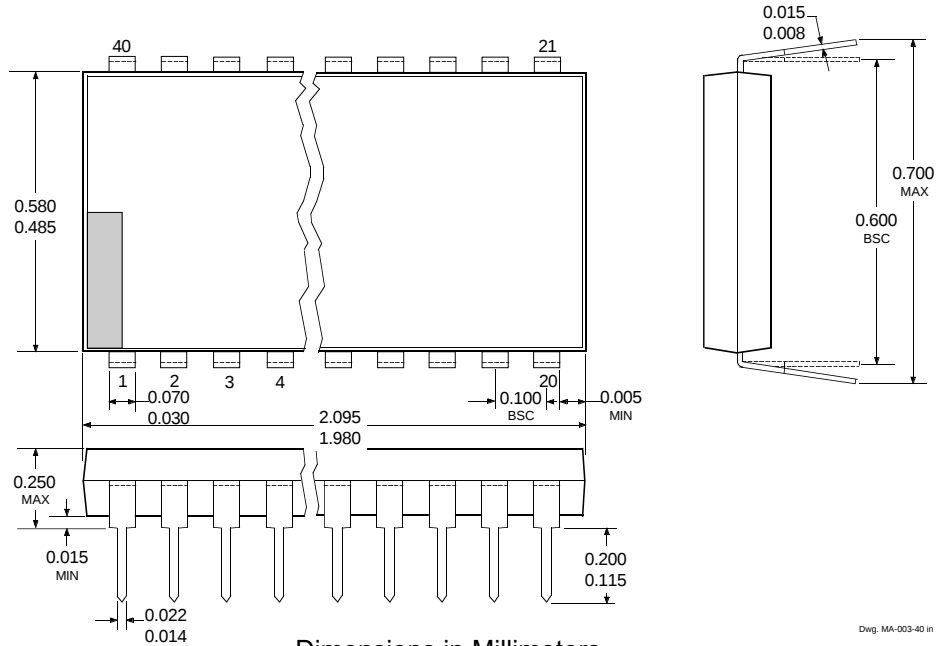


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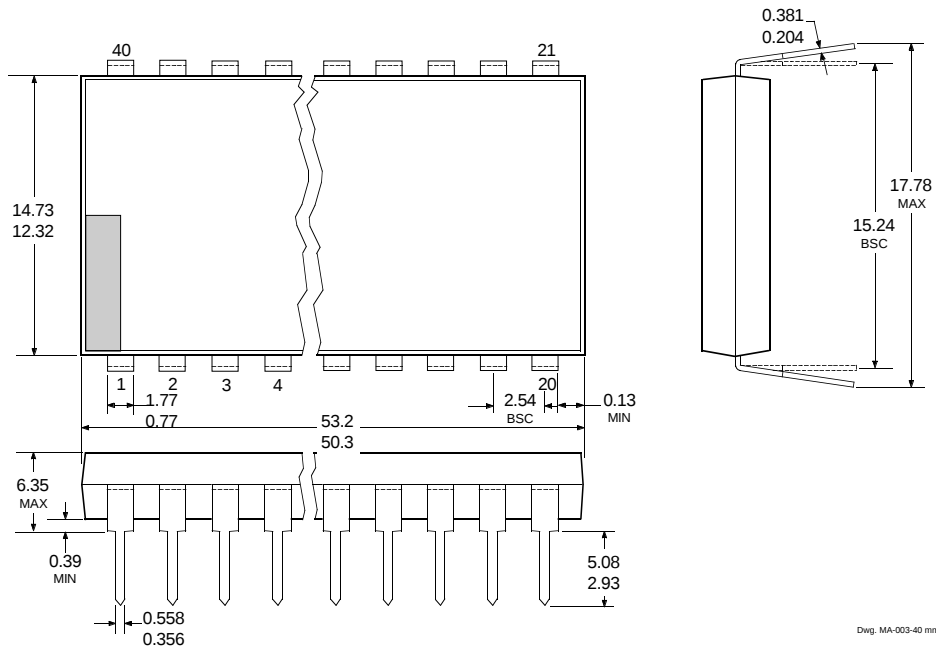
5818-F **32-BIT SERIAL-INPUT,** **LATCHED SOURCE DRIVERS** **WITH ACTIVE-DMOS PULL-DOWNS**

UCN5818AF

Dimensions in Inches
(controlling dimensions)



Dimensions in Millimeters
(for reference only)



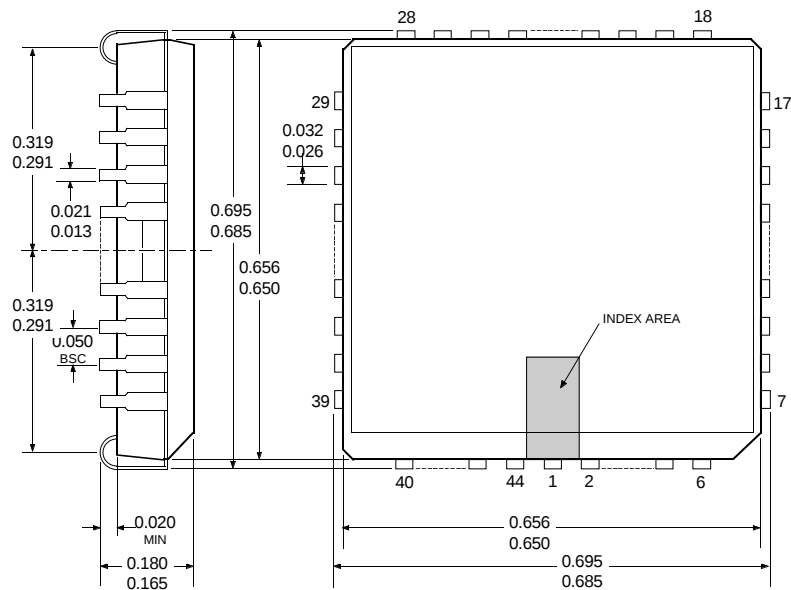
- NOTES:
1. Exact body and lead configuration at vendor's option within limits shown.
 2. Lead spacing tolerance is non-cumulative.
 3. Lead thickness is measured at seating plane or below.
 4. Supplied in standard sticks/tubes of 9 devices.

5818-F

32-BIT SERIAL-INPUT, LATCHED SOURCE DRIVERS WITH ACTIVE-DMOS PULL-DOWNS

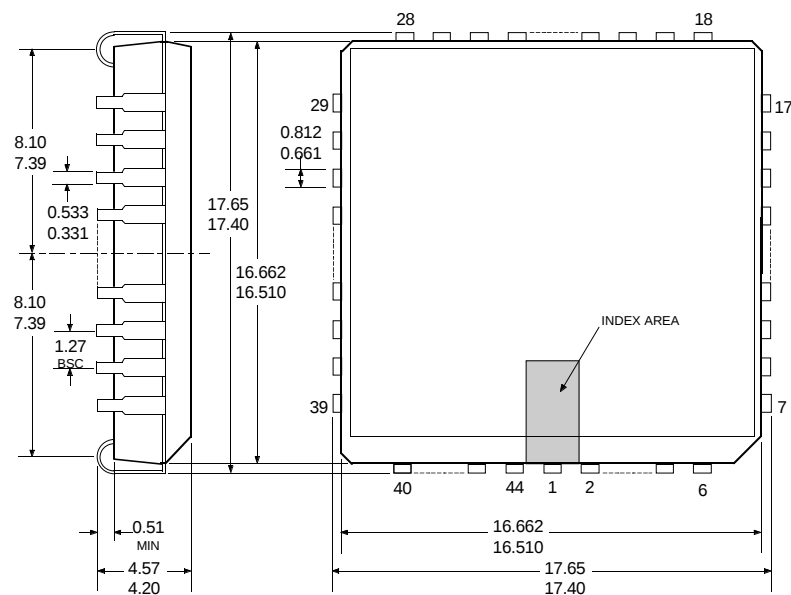
UCN5818EPF

Dimensions in Inches
(controlling dimensions)



Dwg. MA-005-44A in

Dimensions in Millimeters
(for reference only)



Dwg. MA-005-44A mm

- NOTES: 1. Exact body and lead configuration at vendor's option within limits shown.
2. Lead spacing tolerance is non-cumulative.
3. Supplied in standard sticks/tubes of 27 devices or add "TR" to part number for tape and reel.

5818-F
32-BIT SERIAL-INPUT,
LATCHED SOURCE DRIVERS
WITH ACTIVE-DMOS PULL-DOWNS

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5818-F
32-BIT SERIAL-INPUT,
LATCHED SOURCE DRIVERS
WITH ACTIVE-DMOS PULL-DOWNS

POWER
INTERFACE DRIVERS

Function	Output Ratings*		Part Number†
SERIAL-INPUT LATCHED DRIVERS			
8-Bit (saturated drivers)	-120 mA	50 V‡	5895
8-Bit	350 mA	50 V	5821
8-Bit	350 mA	80 V	5822
8-Bit	350 mA	50 V‡	5841
8-Bit	350 mA	80 V‡	5842
8-Bit (constant-current LED driver)	75 mA	17 V	6275
8-Bit (constant-current LED driver)	120 mA	24 V	6277
8-Bit (DMOS drivers)	250 mA	50 V	6595
8-Bit (DMOS drivers)	350 mA	50 V‡	6A595
8-Bit (DMOS drivers)	100 mA	50 V	6B595
10-Bit (active pull-downs)	-25 mA	60 V	5810-F and 6810
12-Bit (active pull-downs)	-25 mA	60 V	5811
16-Bit (constant-current LED driver)	75 mA	17 V	6276
20-Bit (active pull-downs)	-25 mA	60 V	5812-F and 6812
32-Bit (active pull-downs)	-25 mA	60 V	5818-F and 6818
32-Bit	100 mA	30 V	5833
32-Bit (saturated drivers)	100 mA	40 V	5832
PARALLEL-INPUT LATCHED DRIVERS			
4-Bit	350 mA	50 V‡	5800
8-Bit	-25 mA	60 V	5815
8-Bit	350 mA	50 V‡	5801
8-Bit (DMOS drivers)	100 mA	50 V	6B273
8-Bit (DMOS drivers)	250 mA	50 V	6273
SPECIAL-PURPOSE DEVICES			
Unipolar Stepper Motor Translator/Driver	1.25 A	50 V‡	5804
Addressable 8-Bit Decoder/DMOS Driver	250 mA	50 V	6259
Addressable 8-Bit Decoder/DMOS Driver	350 mA	50 V‡	6A259
Addressable 8-Bit Decoder/DMOS Driver	100 mA	50 V	6B259
Addressable 28-Line Decoder/Driver	450 mA	30 V	6817

* Current is maximum specified test condition, voltage is maximum rating. See specification for sustaining voltage limits. Negative current is defined as coming out of (sourcing) the output.

† Complete part number includes additional characters to indicate operating temperature range and package style.

‡ Internal transient-suppression diodes included for inductive-load protection.



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